Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/648,238	CHOI ET AL.
Examiner	Art Unit
Jim Vannucci	2828

	SEARCHED				
Class	Subclass	Date	Examiner		
372	32	6/6/2005	٦V		
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
ollimator, beam splitter, filter, ontroller, TEC	6/6/2005	JV
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